

**Search Notes**

Application/Control No.

09/922,945

Examiner

Minh Dieu Nguyen

Applicant(s)/Patent under  
Reexamination

FUKASAWA, MIKIO

Art Unit

2137

**SEARCHED**

Class	Subclass	Date	Examiner
713	200	6/21/2005	MDN
718	102-103	6/21/2005	MDN
709	224	6/21/2005	MDN
705	51-52	6/21/2005	MDN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PGPUB; EPO; JPO; IBM-TDB; DERWENT)	6/21/2005	MDN
Updated search on EAST (US-PAT; US-PGPUB; EPO; JPO; IBM-TDB; DERWENT)	6/21/2005	MDN
NPL search (Fast and Focused search)	6/21/2005	MDN
Consulted M. Smithers on claims 1 and 14	6/21/2005	MDN
Consulted with C. Revak on claims 1 and 14	6/21/2005	MDN
Consulted with M. Banankhah, AU 2195 on class 718 for claims 1 and 14	6/21/2005	MDN